

Scan chain encryption in Test Standards

Mathieu da Silva, Giorgio Di Natale, Marie-Lise Flottes, Bruno Rouzeyre

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SCAN CHAIN ENCRYPTION IN TEST STANDARDS

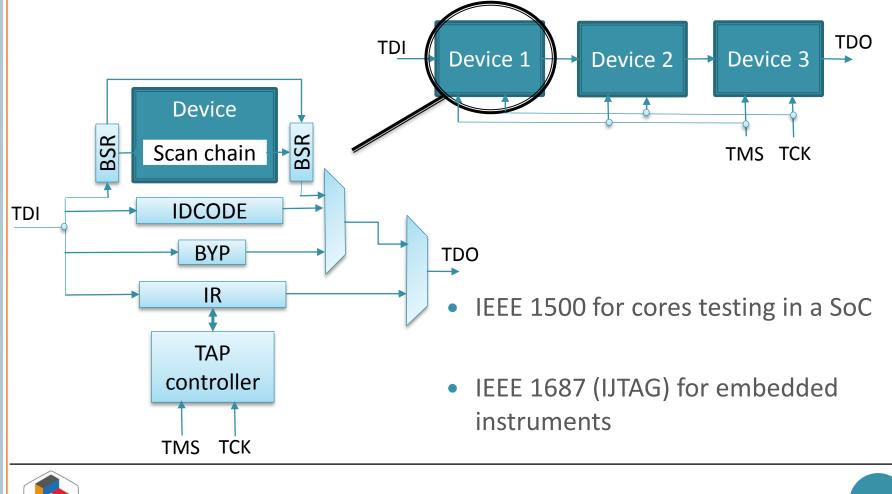
Mathieu Da Silva, Marie-Lise Flottes, Giorgio Di Natale, Bruno Rouzeyre

SURREALIST 2018

CONTEXT



• IEEE 1149 (JTAG) for board testing



01/06/2018

CONTEXT

o Threats Unauthorized Malicious device user TDO TDI Device 1 Device 3 Device BSR BSR Scan chain TMS TCK **IDCODE** TDI Untrusted devices BYP TDO Rosenfeld et al., Attacks and Defenses for JTAG, IEEE Design & Test 2010 IR Malicious users TAP (example: scan attacks) controller Yang et al., Secure Scan: A Design-for-Test Architecture for Crypto Chips, TCAD'06 TMS ТСК



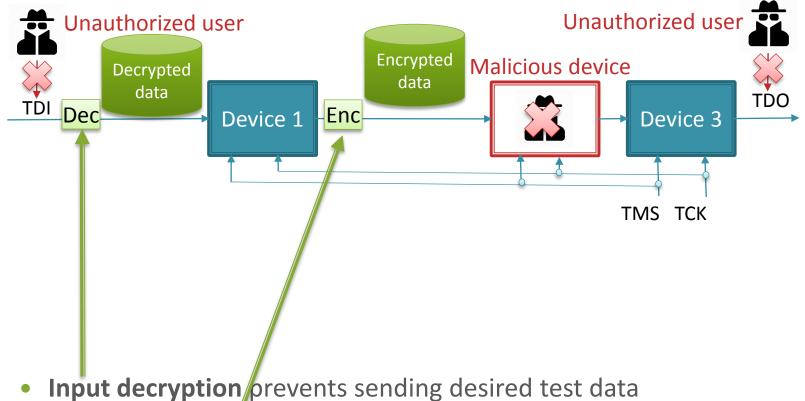
SUMMARY

- **1)** Scan chain encryption
- 2) State-of-the-art based on test communication encryption
- 3) Implementation with block cipher
- 4) Implementation with stream cipher
- 5) Conclusion



SCAN CHAIN ENCRYPTION

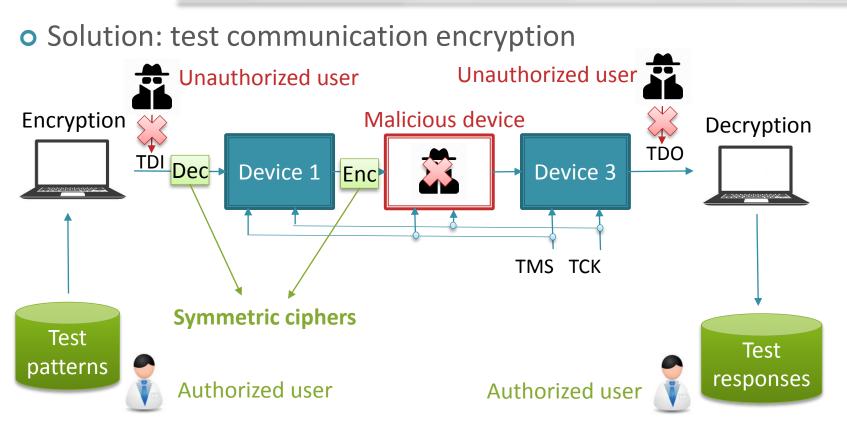
• Solution: test communication encryption



• **Output encryption** prevents reading plain test responses



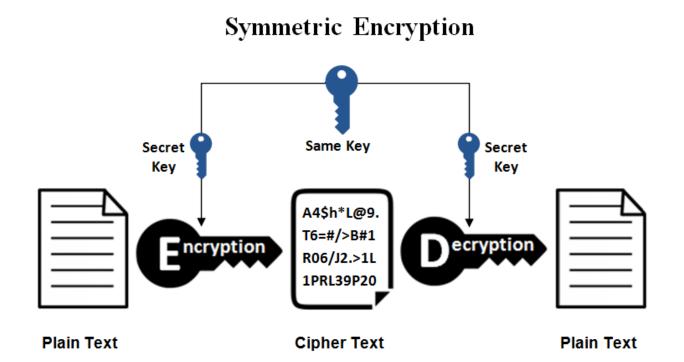
SCAN CHAIN ENCRYPTION



- Input decryption prevents sending desired test data
- Output encryption prevents reading plain test responses
- Test/debug only possible by authorized user knowing the secret key



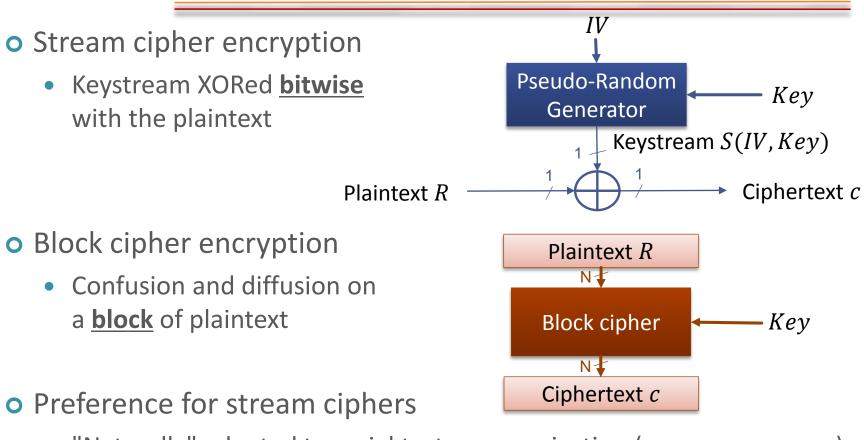
Symmetric cipher



• 2 types of symmetric cipher: stream and block ciphers



STREAM CIPHER / BLOCK CIPHER

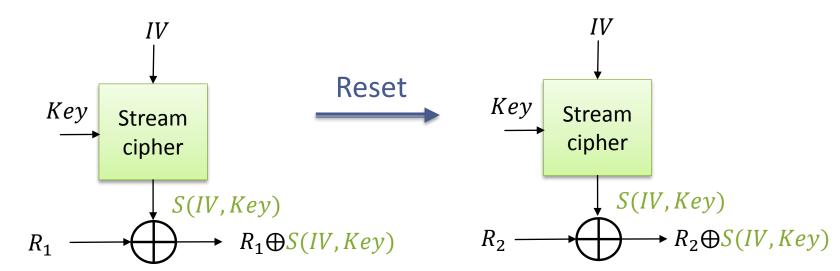


- "Naturally" adapted to serial test communication (JTAG, IEEE 1500, IJTAG)
- Smaller area footprint compared to block ciphers
- But ..



TWO-TIMES PAD: STREAM CIPHER REQUIREMENT

• **Two-times pad**: same key and *IV* re-used => same keystream generated to encrypt different data



 \Rightarrow Possible to carry out attacks if requirement is not fit

 $R1 \oplus S(W, Key) \oplus R2 \oplus S(W, Key)$

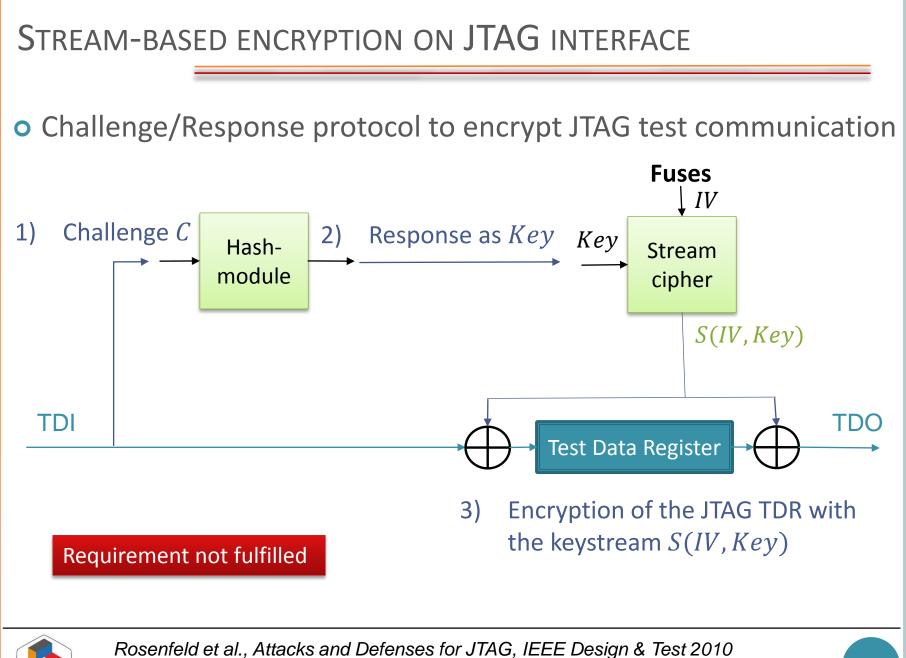
 $\Rightarrow \text{ Solution: } IV \text{ generated randomly at each circuit reset} \\ R1 \bigoplus S(IV_1, Key) \bigoplus R2 \bigoplus S'(IV_2, Key)$



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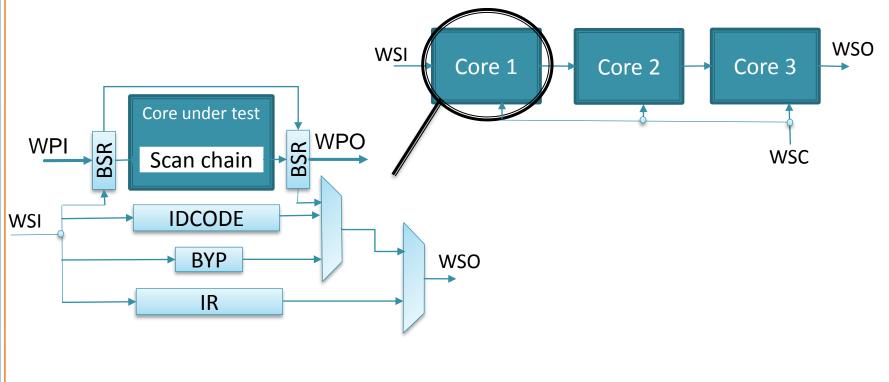


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STREAM-BASED ENCRYPTION ON IEEE 1500 INTERFACE

• IEEE 1500 standard

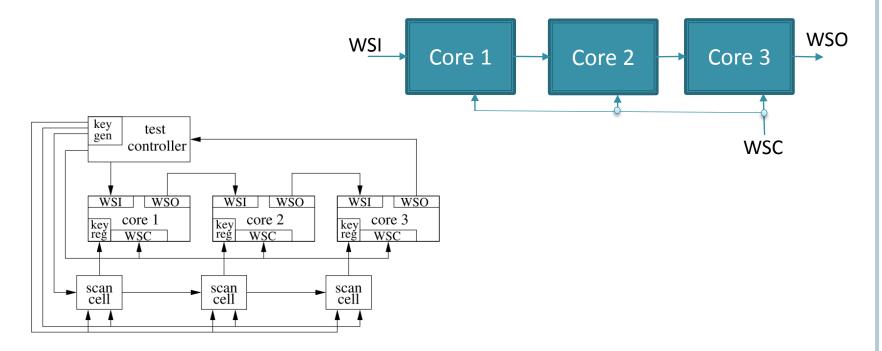
- Similar as JTAG standard, but for SoC wrappers
- Parallel test inputs WPI and parallel test outputs WPO





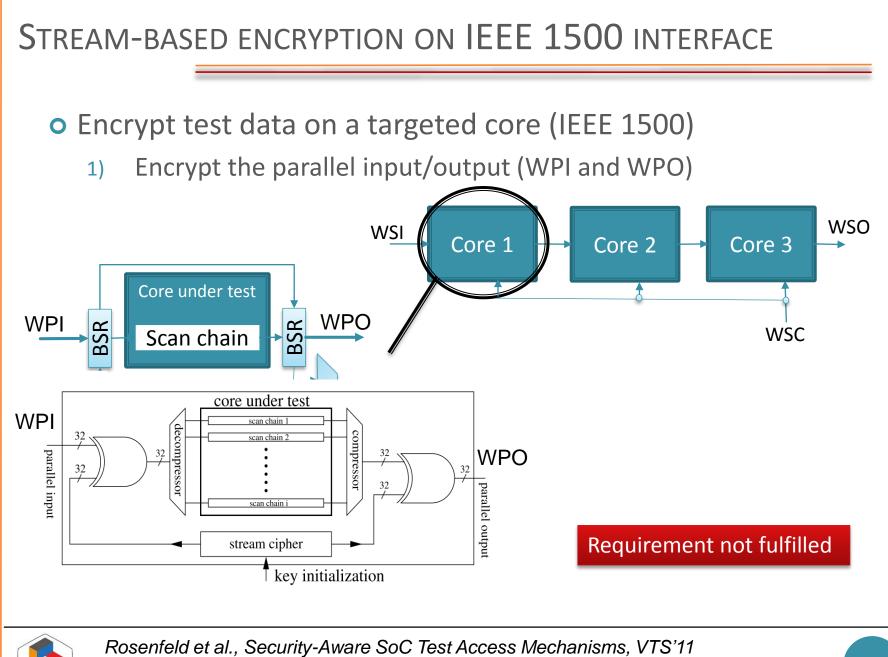
STREAM-BASED ENCRYPTION ON IEEE 1500 INTERFACE

- Encrypt test data on a targeted core (IEEE 1500)
 - 1) Send the key to the core via specific scan chain non-visible from the others cores





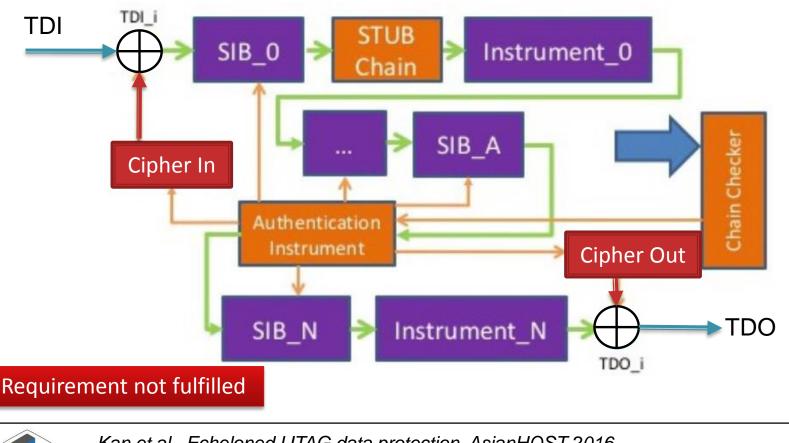
Rosenfeld et al., Security-Aware SoC Test Access Mechanisms, VTS'11



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STREAM-BASED ENCRYPTION ON IJTAG INTERFACE

• Encryption of Test Data Register associated to Instruments in the IJTAG network

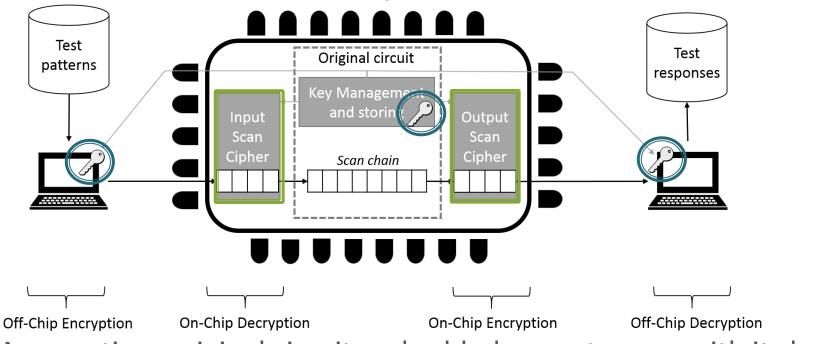




Kan et al., Echeloned IJTAG data protection, AsianHOST 2016.

OUR PROPOSITION

• Insertion of block or stream ciphers at Scan-In and Scan-Out



- Assumption: original circuit embedded a crypto-core with its key management and storing
- Scan chain encryption solution shares the key management and storing already implemented



SUMMARY

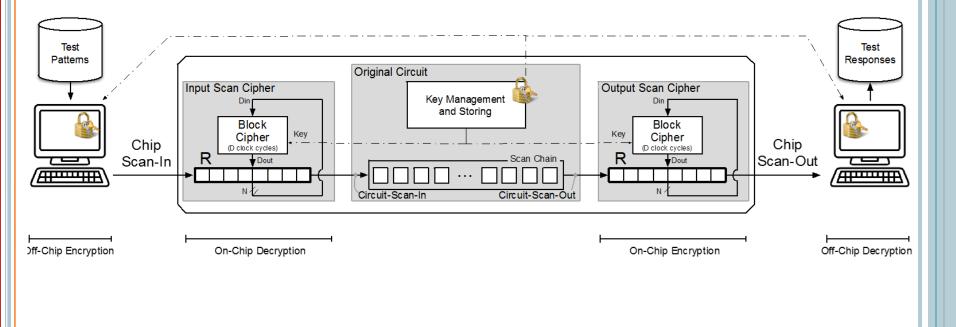
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BLOCK CIPHER-BASED SCAN ENCRYPTION

• Implementation on scan chain with 2 PRESENT block ciphers:

- Lightweight (1 PRESENT = 2 139 GE)
- Encryption by 64-bits block size

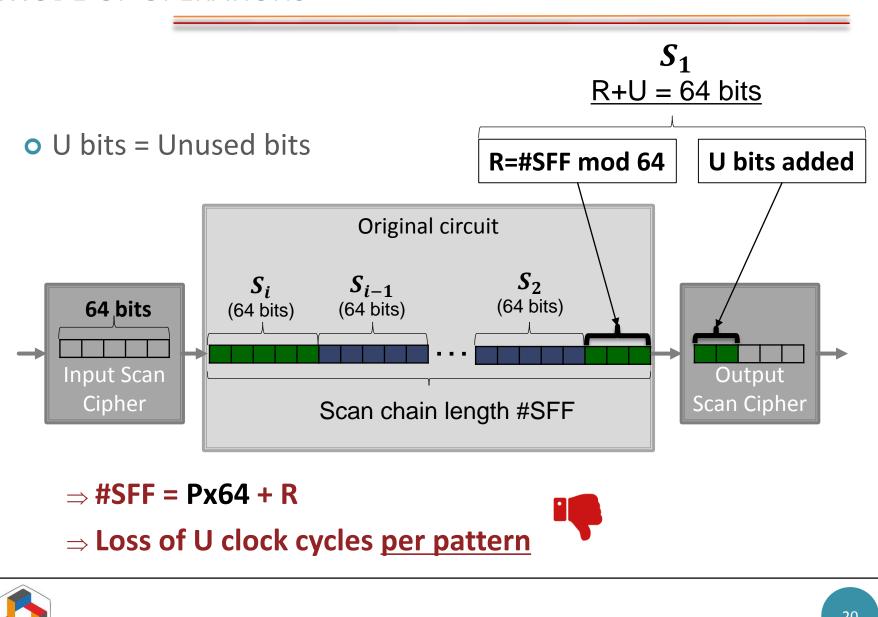




MODE OF OPERATIONS • 64 bits encrypted every 32 clock cycles **Original circuit** S_2 S_1 S_i S_{i-1} 64 bits (64 bits) (64 bits) (64 bits) (64 bits) Input Scan Output Cipher Scan Cipher Scan chain length #SFF \Rightarrow #SFF = Px64 \Rightarrow No test time overhead on each pattern



MODE OF OPERATIONS



SUMMARY

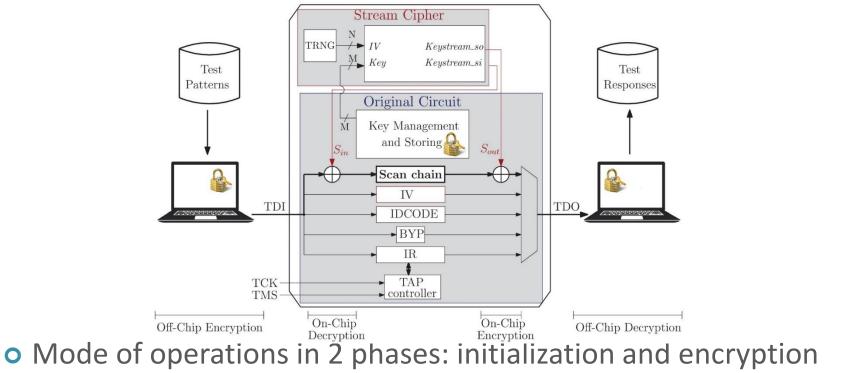
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STREAM CIPHER-BASED SCAN ENCRYPTION

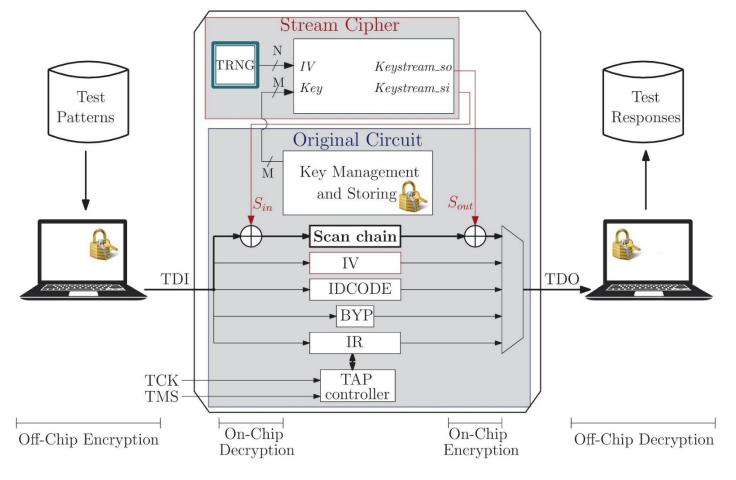
• Implementation on JTAG:

- 1 TRIVIUM stream cipher (2 016 GE)
- TRNG to generate random IV
- New instruction *GetIV* with a test data register IV

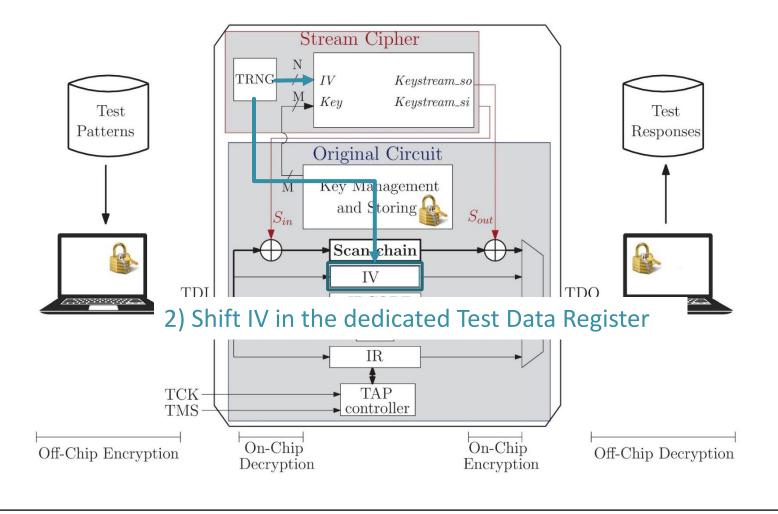




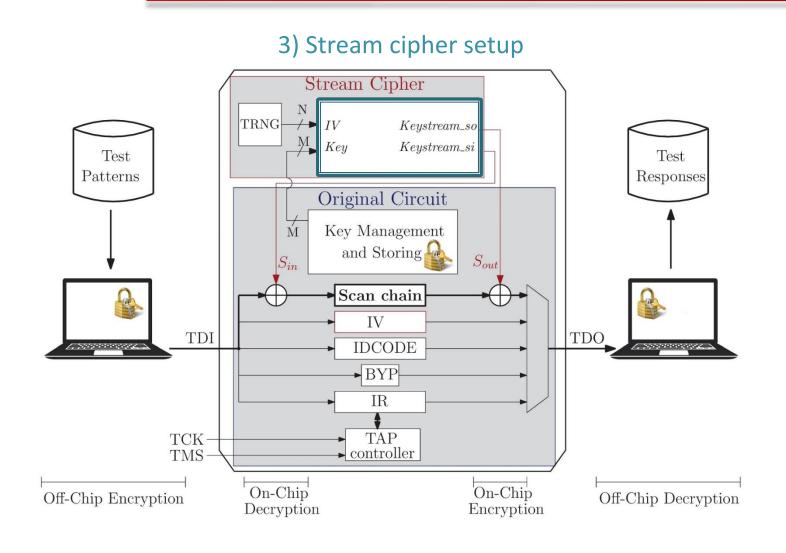
1) TRNG initialization: reach sufficient entropy to generate random number



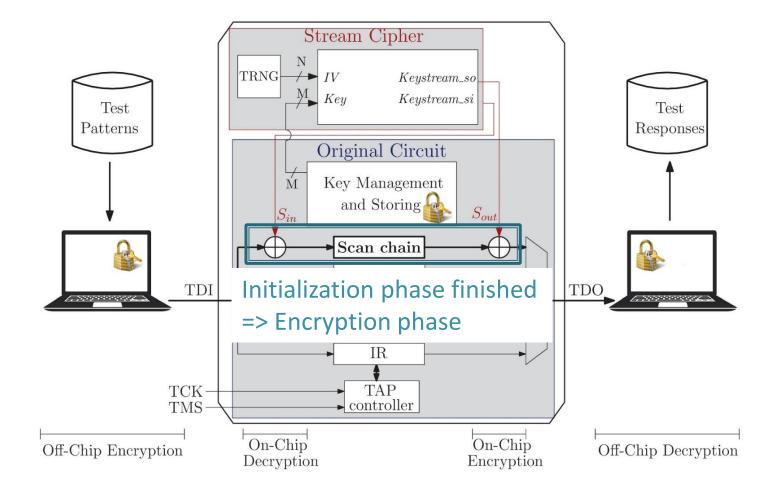










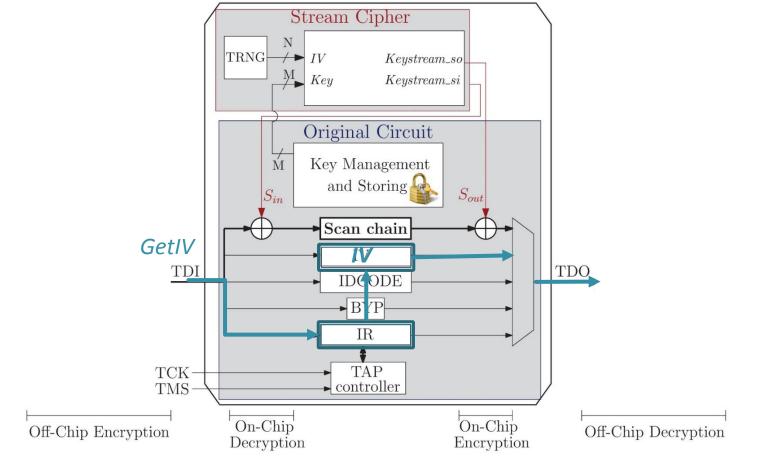




ENCRYPTION PHASE

• User sends GETIV instruction

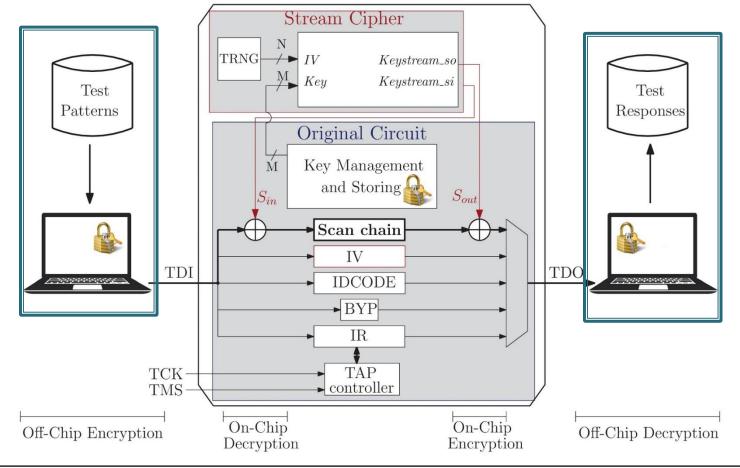
 \Rightarrow Shift the content of the IV register out the circuit





ENCRYPTION PHASE

• User can encrypt and decrypt test data with the **obtained** *IV* and the **shared secret key**





TIME FOR THE INITIALIZATION PROCESS

- $T_{TRNG_{init}}$ to initialize the TRNG
- 80 clock cycles to shift the *IV* in the register
- o 1 152 clock cycles for the stream cipher setup

Original circuit	Triple-DES	Pipelined AES-128	Pipelined AES-256	RSA 1024	LEON3
Test time* (clock cycles)	687 101	1 944 877	4 559 845	39 405 239	11 612 051
Test time overhead					
Block-based solution (%)	+0.31	+0.81	+0.006	+0.33	+0.004
Stream-based solution (%)**	+0.18	+0.06	+0.03	+0.003	+0.01

*: Test time considered for a fault coverage of 100%, except for LEON3 where it reaches 70%

**: test time overhead without the initialization of the TRNG



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COMPARISON BETWEEN BOTH SOLUTIONS

	Block cipher-based solution (PRESENT)	Stream cipher-based solution (TRIVIUM)				
Security						
- Scan attacks	Protected	Protected (two times pad not possible)				
- Malicious core	Protected	Protected				
Cost						
- Area	10 658.96 μm²	5 408.52 μm² (+ 31 200 μm² for TRNG)				
- Test time	Depends on the scan length (multiple or not of the block size)	Clock cycles required for the initialization phase				
Integration						
- Diagnosis & debug	Still possible in-field					
- Key management	Re-use key management already implemented					
 Integration in test daisy-chain 	Possible issue with the padding of test data	No issue				





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• Partners



